Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/653,327	CHEN, CHIH-WEI
- Examiner	Art Unit
Anish Sikri	2143

SEARCHED				
Class	Subclass	Date	Examiner	
709	223	10/11/2007	AS	
709	225	10/11/2007	AS	
•				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH S		<b>)</b>
	DATE	EXMR
East Image and Keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO and IBM_TDB (see attached search strategy)	10/11/2007	AS
Inventor name and Assignee search in PALM ExPO and EAST	10/11/2007	AS
S132 and (("hard disk" or harddisk) near3 settings)	10/11/2007	AS
S132 and ((harddisk or "hard disk" or memory) near3 (config\$7 or set\$4))	10/11/2007	AS
S146 and "709"/\$.ccls.		